Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10522648	SEKIYA, HIROSHI
Examiner	Art Unit
Dinh Q Nauven	3752

	Examiner Dinh Q Nguyen	Art Unit 3752

SEARCHED			
Class	Subclass	Date	Examiner
239	290,292,295,77,296	3/31/08	DN
101	147,148,424.1	3/31/08	DN
	updated search	10/26/08	DN

SEARCH NOTES		
Search Notes	Date	Examiner
East search attached	3/31/08	DN

INTERFERENCE SEARCH			
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